## Notice of References Cited Application/Control No. 10/748,809 Examiner Paul J. Hirsch Applicant(s)/Patent Under Reexamination LEE ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,886,873	03-1999	Ahn, Seong-Ick	361/719
*	В	US-6,607,023	08-2003	Ho et al.	165/78
*	С	US-6,644,386	11-2003	Hsu, Wen-Tsai	165/80.3
*	D	US-6,672,379	01-2004	Wang et al.	165/185
	Е	US-			
	F	US-			
	G	US-			
	Н	US-			
	_	US-			
	7	US-			
	K	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Z					
	0				100	
	P					
	Q					
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
<u>.</u>	٧	
	w	
	х	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.